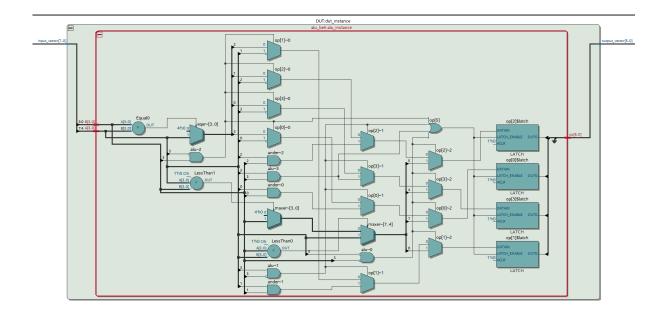
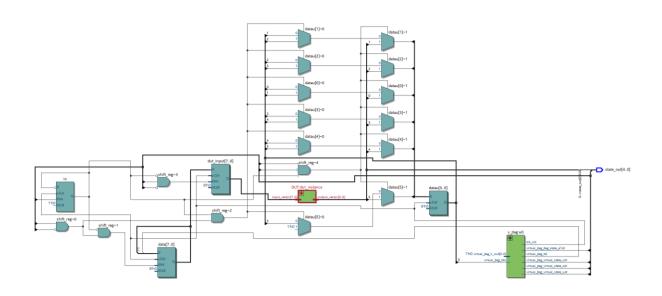
EE214 Digital Circuits Laboratory

EXP5 – Behavioral and Dataflow Modelling

Swarup Dasharath Patil 22b3953

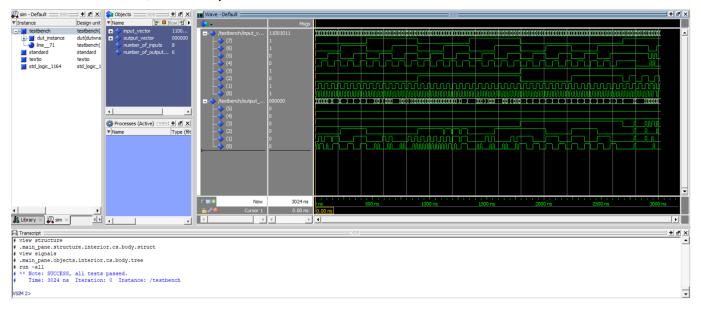
RTL Viewer:





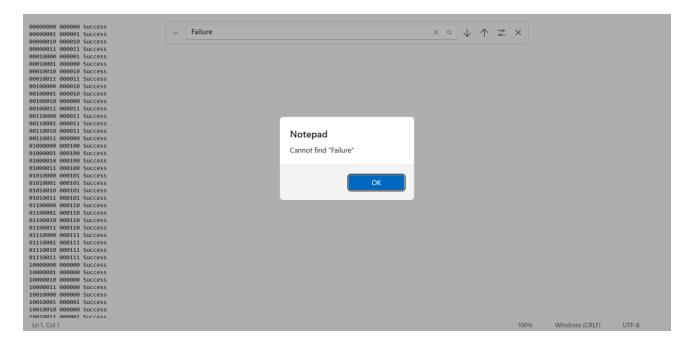
RTL Simulation:

Note: SUCCESS, all tests passed.



Scanchain based testing:

All tests were successful.



Lab Journal:

A rough pen-paper design of the circuit verified by the TA.

